Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/652,153	FEDER ET AL.	
Examiner	Art Unit	
Dustin Nguyen	2154	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	235, 448	3/1/2006	DN
709	232	3/1/2006	DN

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
370	235, 280	3/1/2006	DN		
370	445, 448	3/1/2006	DN		
709	232, 235	3/1/2006	DN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated search EAST, ACM, IEEE and google	3/1/2006	DN		
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